

# LM611 Operational Amplifier and Adjustable Reference

Check for Samples: LM611

### **FEATURES**

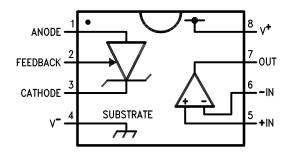
#### OP AMP

- Low Operating Current: 300 μA (op amp)
- Wide Supply Voltage Range: 4V to 36V
- Wide Common-Mode Range: V<sup>-</sup> to (V<sup>+</sup>−1.8V)
- Wide Differential Input Voltage: ±36V
- Available in Low Cost 8-pin DIP
- Available in Plastic Package Rated for Military Temperature Range Operation REFERENCE
- Adjustable Output Voltage: 1.2V to 6.3V
- Tight Initial Tolerance Available: ±0.6%
- Wide Operating Current Range: 17 μA to 20 mA
- Reference Floats Above Ground
- Tolerant of Load Capacitance

### **APPLICATIONS**

- Transducer Bridge Driver
- Process and Mass Flow Control Systems
- Power Supply Voltage Monitor
- Buffered Voltage References for A/D's

#### **Connection Diagrams**





### **DESCRIPTION**

The LM611 consists of a single-supply op-amp and a programmable voltage reference in one space saving 8-pin package. The op-amp out-performs most single-supply op-amps by providing higher speed and bandwidth along with low supply current. This device was specifically designed to lower cost and board space requirements in transducer, test, measurement and data acquisition systems.

Combining a stable voltage reference with a wide output swing op-amp makes the LM611 ideal for single supply transducers, signal conditioning and bridge driving where large common-mode signals are common. The voltage reference consists of a reliable band-gap design that maintains low dynamic output impedance (1 $\Omega$  typical), excellent initial tolerance (0.6%), and the ability to be programmed from 1.2V to 6.3V via two external resistors. The voltage reference is very stable even when driving large capacitive loads, as are commonly encountered in CMOS data acquisition systems.

As a member of TI's Super-Block family, the LM611 is a space-saving monolithic alternative to a multichip solution, offering a high level of integration without sacrificing performance.

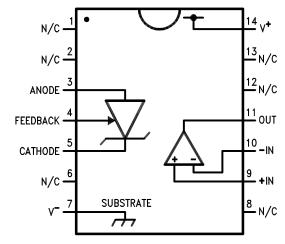


Figure 2. Plastic Surface Mount Narrow Package

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

All trademarks are the property of their respective owners.





These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

# Absolute Maximum Ratings (1)(2)

| Voltage on Any Pins Except V <sub>R</sub> (referred to V <sup>-</sup> pin) | 36V (Max)                    |
|--|------------------------------|
| See <sup>(3)</sup>   | -0.3V (Min)                  |
| Current through Any Input Pin and V <sub>R</sub> Pin                       | ±20 mA                       |
| Differential Input Voltage   |                              |
| Military and Industrial  | ±36V                         |
| Commercial   | ±32V                         |
| Storage Temperature Range  | -65°C≤T <sub>J</sub> ≤+150°C |
| Maximum Junction Temperature   | 150°C                        |
| Thermal Resistance, Junction-to-Ambient (4)                                |                              |
| N Package  | 100°C/W                      |
| D Package  | 150°C/W                      |
| Soldering Information Soldering (10 seconds)                               |                              |
| N Package  | 260°C                        |
| D Package  | 220°C                        |
| ESD Tolerance <sup>(5)</sup>   | ±1 kV                        |

- (1) Absolute maximum ratings indicate limits beyond which damage to the component may occur. Electrical specifications do not apply when operating the device beyond its rated operating conditions.
- (2) If Military/Aerospace specified devices are required, please contact the Texas Instruments Sales Office/ Distributors for availability and specifications.
- (3) More accurately, it is excessive current flow, with resulting excess heating, that limits the voltages on all pins. When any pin is pulled a diode drop below V<sup>-</sup>, a parasitic NPN transistor turns ON. No latch-up will occur as long as the current through that pin remains below the Maximum Rating. Operation is undefined and unpredictable when any parasitic diode or transistor is conducting.
- (4) Junction temperature may be calculated using T<sub>J</sub> = T<sub>A</sub> + P<sub>D</sub> θ<sub>JA</sub>. The given thermal resistance is worst-case for packages in sockets in still air. For packages soldered to copper-clad board with dissipation from one op amp or reference output transistor, nominal θ<sub>JA</sub> is 90°C/W for the N package and 135°C/W for the D package.
- (5) Human body model, 100 pF discharged through a 1.5 k $\Omega$  resistor.

### **Operating Temperature Range**

| LM611AI, LM611I, LM611BI | -40°C≤T <sub>J</sub> ≤+85°C  |
|--------------------------|------------------------------|
| LM611AM, LM611M          | -55°C≤T <sub>J</sub> ≤+125°C |
| LM611C                   | 0°C≤T <sub>J</sub> ≤70°C     |



# Electrical Characteristics(1)

These specifications apply for  $V^- = \text{GND} = 0\text{V}$ ,  $V^+ = 5\text{V}$ ,  $V_{\text{CM}} = V_{\text{OUT}} = 2.5\text{V}$ ,  $I_R = 100~\mu\text{A}$ , FEEDBACK pin shorted to GND, unless otherwise specified. Limits in standard typeface are for  $T_J = 25^{\circ}\text{C}$ ; limits in **boldface type** apply over the **Operating Temperature Range.** 

| Symbol                 | mbol Parameter Conditions            |  | Typical <sup>(2)</sup>                       | LM611AM<br>LM611AI<br>Limits <sup>(3)</sup>  | LM611M<br>LM611BI<br>LM611I<br>LM611C<br>Limits <sup>(3)</sup> | Units            |
|------------------------|--------------------------------------|--|--|--|--|------------------|
| I <sub>S</sub>         | Total Supply Current                 | $R_{LOAD} = \infty$ ,<br>$4V \le V^+ \le 36V$ (32V for LM611C)   | 210<br><b>221</b>                            | 300<br><b>320</b>                            | 350<br><b>370</b>  | μΑ max<br>μΑ max |
| V <sub>S</sub>         | Supply Voltage Range                 |  | 2.2<br><b>2.9</b>                            | 2.8<br><b>3</b>                              | 2.8<br><b>3</b>  | V min<br>V min   |
|                        |                                      |  | 46<br><b>43</b>                              | 36<br><b>36</b>                              | 32<br><b>32</b>  | V max<br>V max   |
| OPERATION              | IAL AMPLIFIER                        | •  | ·  |  |  | •                |
| V <sub>OS1</sub>       | V <sub>OS</sub> Over Supply          | 4V ≤ V <sup>+</sup> ≤ 36V<br>(4V ≤ V <sup>+</sup> ≤ 32V for LM611C)  | 1.5<br><b>2.0</b>                            | 3.5<br><b>6.0</b>                            | 5.0<br><b>7.0</b>  | mV max<br>mV max |
| V <sub>OS2</sub>       | V <sub>OS</sub> Over V <sub>CM</sub> | $V_{CM} = 0V$ through $V_{CM} = (V^+ - 1.8V), V^+ = 30V, V^- = 0V$   | 1.0<br><b>1.5</b>                            | 3.5<br><b>6.0</b>                            | 5.0<br><b>7.0</b>  | mV max<br>mV max |
| V <sub>OS3</sub><br>ΔT | Average V <sub>OS</sub> Drift        | See <sup>(3)</sup>   | 15   |  |  | μV/°C<br>max     |
| I <sub>B</sub>         | Input Bias Current                   |  | 10<br><b>11</b>                              | 25<br><b>30</b>                              | 35<br><b>40</b>  | nA max<br>nA max |
| I <sub>OS</sub>        | Input Offset Current                 |  | 0.2<br><b>0.3</b>                            | 4<br>5                                       | 4<br><b>5</b>  | nA max<br>nA max |
| I <sub>OS1</sub><br>ΔT | Average Offset Drift<br>Current      |  | 4  |  |  | pA/°C            |
| R <sub>IN</sub>        | Input Resistance                     | Differential   | 1800   |  |  | ΜΩ               |
|                        |                                      | Common-Mode  | 3800   |  |  | ΜΩ               |
| C <sub>IN</sub>        | Input Capacitance                    | Common-Mode  | 5.7  |  |  | pF               |
| e <sub>n</sub>         | Voltage Noise                        | f = 100 Hz,<br>Input Referred  | 74   |  |  | nV/ √Hz          |
| I <sub>n</sub>         | Current Noise                        | f = 100 Hz,<br>Input Referred  | 58   |  |  | fA/√Hz           |
| CMRR                   | Common-Mode<br>Rejection-Ratio       | $V^{+} = 30V, 0V \le V_{CM} \le (V^{+} - 1.8V)$<br>CMRR = 20 log ( $\Delta V_{CM}/\Delta V_{OS}$ )                   | 95<br><b>90</b>                              | 80<br><b>75</b>                              | 75<br><b>70</b>  | dB min<br>dB min |
| PSRR                   | Power Supply<br>Rejection-Ratio      | $4V \le V^+ \le 30V$ , $V_{CM} = V^+/2$ ,<br>PSRR = 20 log $(\Delta V^+/\Delta V_{OS})$                              | 110<br><b>100</b>                            | 80<br><b>75</b>                              | 75<br><b>70</b>  | dB min<br>dB min |
| A <sub>V</sub>         | Open Loop<br>Voltage Gain            | $R_L = 10 \text{ k}\Omega \text{ to GND, V}^+ = 30\text{V},$<br>$5\text{V} \le \text{V}_{\text{OUT}} \le 25\text{V}$ | 500<br><b>50</b>                             | 100<br><b>40</b>                             | 94<br><b>40</b>  | V/mV<br>min      |
| SR                     | Slew Rate                            | $V^+ = 30V^{(4)}$  | 0.70<br><b>0.65</b>                          | 0.55<br><b>0.45</b>                          | 0.50<br><b>0.45</b>  | V/µs             |
| GBW                    | Gain Bandwidth                       | C <sub>L</sub> = 50 pF   | 0.80<br><b>0.50</b>                          |  |  | MHz              |
| V <sub>O1</sub>        | Output Voltage<br>Swing High         | $R_L = 10 \text{ k}\Omega \text{ to GND}$<br>V <sup>+</sup> = 36V (32V for LM611C)                                   | V <sup>+</sup> - 1.4<br>V <sup>+</sup> - 1.6 | V <sup>+</sup> - 1.7<br>V <sup>+</sup> - 1.9 | V <sup>+</sup> - 1.8<br><b>V<sup>+</sup> - 1.9</b>             | V min<br>V min   |
| V <sub>O2</sub>        | Output Voltage<br>Swing Low          | $R_L = 10 \text{ k}\Omega \text{ to V}^+$<br>V <sup>+</sup> = 36V (32V for LM611C)                                   | V <sup>-</sup> + 0.8<br>V <sup>-</sup> + 0.9 | V <sup>-</sup> + 0.9<br>V <sup>-</sup> + 1.0 | V <sup>-</sup> + 0.95<br><b>V<sup>-</sup> + 1.0</b>            | V max<br>V max   |
| I <sub>OUT</sub>       | Output Source<br>Current             | $V_{OUT} = 2.5V, V_{+IN} = 0V, V_{-IN} = -0.3V$  | 25<br><b>15</b>                              | 20<br><b>13</b>                              | 16<br><b>13</b>  | mA min<br>mA min |
|                        |                                      |  |  |  |  |                  |

<sup>(1)</sup> Military RETS 611AMX electrical test specification is available on request. The LM611AMJ/883 can also be procured as a Standard Military Drawing.

Copyright © 1998–2013, Texas Instruments Incorporated

<sup>(2)</sup> Typical values in standard typeface are for T<sub>J</sub> = 25°C; values in **boldface type** apply for the full operating temperature range. These values represent the most likely parametric norm.

<sup>(3)</sup> All limits are specified at room temperature (standard type face) or at operating temperature extremes (bold face type).

<sup>(4)</sup> Slew rate is measured with op amp in a voltage follower configuration. For rising slew rate, the input voltage is driven from 5V to 25V, and the output voltage transition is sampled at 10V and 20V. For falling slew rate, the input voltage is driven from 25V to 5V, and output voltage transition is sampled at 20V and 10V.



# Electrical Characteristics<sup>(1)</sup> (continued)

These specifications apply for  $V^- = \text{GND} = 0\text{V}$ ,  $V^+ = 5\text{V}$ ,  $V_{\text{CM}} = V_{\text{OUT}} = 2.5\text{V}$ ,  $I_R = 100~\mu\text{A}$ , FEEDBACK pin shorted to GND, unless otherwise specified. Limits in standard typeface are for  $T_J = 25^{\circ}\text{C}$ ; limits in **boldface type** apply over the **Operating Temperature Range**.

|   |  | Conditions   | Typical <sup>(2)</sup> | LM611AM<br>LM611AI<br>Limits <sup>(3)</sup> | LM611M<br>LM611BI<br>LM611I<br>LM611C<br>Limits <sup>(3)</sup> | Units            |
|---|--|--|------------------------|---|--|------------------|
| I <sub>SINK</sub>                       | Output Sink<br>Current                               | $V_{OUT} = 1.6V, V_{+IN} = 0V, V_{-IN} = 0.3V$   | 17<br><b>9</b>         | 14<br><b>8</b>                              | 13<br><b>8</b>   | mA min<br>mA min |
| I <sub>SHORT</sub>                      | Short Circuit Current                                | $V_{OUT} = 0V$ , $V_{+IN} = 3V$ , $V_{-IN} = 2V$ , Source  | 30<br><b>40</b>        | 50<br><b>60</b>                             | 50<br><b>60</b>  | mA max<br>mA max |
|   |  | $V_{OUT} = 5V$ , $V_{+IN} = 2V$ , $V_{-IN} = 3V$ , Sink  | 30<br><b>32</b>        | 60<br><b>80</b>                             | 70<br><b>90</b>  | mA max<br>mA max |
| VOLTAGE R                               | EFERENCE   |  |                        |   |  |                  |
| $V_R$                                   | Reference Voltage                                    | See <sup>(5)</sup>   | 1.244                  | 1.2365<br>1.2515<br>(±0.6%)                 | 1.2191<br>1.2689<br>(±2.0%)                                    | V min<br>V max   |
| $\frac{\Delta V_R}{\Delta T_J}$         | Average Temperature Drift                            | See (6)  | 10                     | 80  | 150  | PPM/°C<br>max    |
| $\frac{\Delta V_R}{\Delta T_J}$         | Hysteresis   | Hyst = $(Vro' - Vro)/\Delta T_J^{(7)}$   | 3.2                    |   |  | μV/°C            |
| $\frac{\Delta V_R}{\Delta I_R}$         | V <sub>R</sub> Change<br>with Current                | V <sub>R(100 μA)</sub> - V <sub>R(17 μA)</sub>   | 0.05<br><b>0.1</b>     | 1<br>1.1                                    | 1<br>1.1   | mV max<br>mV max |
|   |  | V <sub>R(10 mA)</sub> - V <sub>R(100 μA)</sub> (8)   | 1.5<br><b>2.0</b>      | 5<br><b>5.5</b>                             | 5<br><b>5.5</b>  | mV max<br>mV max |
| R                                       | Resistance   | $\Delta V_{R(10 \to 0.1 \text{ mA})}/9.9 \text{ mA}  \Delta V_{R(100 \to 17 \mu A)}/83 \mu A$                                    | 0.2<br>0.6             | 0.56<br>13                                  | 0.56<br>13   | Ω max<br>Ω max   |
| $\frac{\Delta V_R}{V_{RO}}$             | V <sub>R</sub> Change with<br>High V <sub>RO</sub>   | V <sub>R(Vro = Vr)</sub> - V <sub>R(Vro = 6.3V)</sub><br>(5.06V between Anode and<br>FEEDBACK)                                   | 2.5<br><b>2.8</b>      | 7<br><b>10</b>                              | 7<br><b>10</b>   | mV max<br>mV max |
| $\frac{\Delta V_R}{\Delta V_+}$         | V <sub>R</sub> Change with V <sup>+</sup> Change     | $V_{R(V+=5V)} - V_{R(V+=36V)}$<br>(V <sup>+</sup> = 32V for LM611C)  | 0.1<br><b>0.1</b>      | 1.2<br><b>1.3</b>                           | 1.2<br><b>1.3</b>  | mV max<br>mV max |
|   |  | $V_{R(V+=5V)} - V_{R(V+=3V)}$  | 0.01<br><b>0.01</b>    | 1<br>1.5                                    | 1<br>1.5   | mV max<br>mV max |
| $\frac{\Delta V_{R}}{\Delta V_{ANODE}}$ | V <sub>R</sub> Change with V <sub>ANODE</sub> Change | $V^{+} = V^{+} \text{ max}, \Delta V_{R} = V_{R}$<br>(@ $V_{ANODE} = V^{-} = GND$ ) - $V_{R}$<br>(@ $V_{ANODE} = V^{+} - 1.0V$ ) | 0.7<br><b>3.3</b>      | 1.5<br><b>3.0</b>                           | 1.6<br><b>3.0</b>  | mV max<br>mV max |
| I <sub>FB</sub>                         | FEEDBACK Bias<br>Current                             | $I_{FB}$ ; $V_{ANODE} \le V_{FB} \le 5.06V$  | 22<br><b>29</b>        | 35<br><b>40</b>                             | 50<br><b>55</b>  | nA max<br>nA max |
| e <sub>n</sub>                          | V <sub>R</sub> Noise                                 | 10 Hz to 10,000 Hz, V <sub>RO</sub> = V <sub>R</sub>   | 30                     |   |  | $\mu V_{RMS}$    |

<sup>(5)</sup>  $V_R$  is the cathode-feedback voltage, nominally 1.244V.

(8) Low contact resistance is required for accurate measurement.

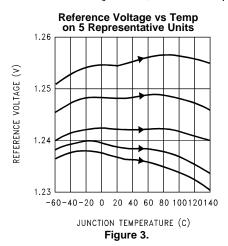
<sup>(6)</sup> Average reference drift is calculated from the measurement of the reference voltage at 25°C and at the temperature extremes. The drift, in ppm/°C, is 10<sup>6</sup>•ΔV<sub>R</sub>/(V<sub>R[25°C]</sub>•ΔT<sub>J</sub>), where ΔV<sub>R</sub> is the lowest value subtracted from the highest, V<sub>R[25°C]</sub> is the value at 25°C, and ΔT<sub>J</sub> is the temperature range. This parameter is ensured by design and sample testing.

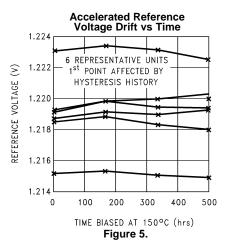
<sup>(7)</sup> Hysteresis is the change in V<sub>R</sub> caused by a change in T<sub>J</sub>, after the reference has been "dehysterized". To dehysterize the reference; that is minimize the hysteresis to the typical value, its junction temperature should be cycled in the following pattern, spiraling in toward 25°C: 25°C, 85°C, -40°C, 70°C, 0°C, 25°C.

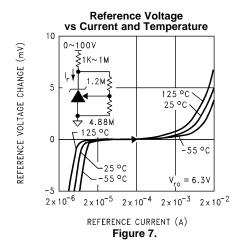


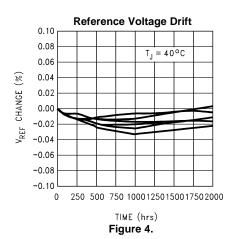
### **Typical Performance Characteristics (Reference)**

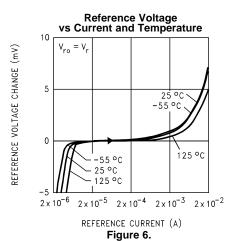
 $T_J = 25$ °C, FEEDBACK pin shorted to  $V^- = 0V$ , unless otherwise noted

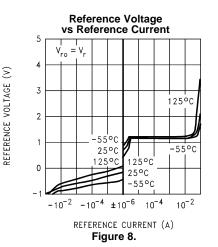














# Typical Performance Characteristics (Reference) (continued)

 $T_J = 25$ °C, FEEDBACK pin shorted to  $V^- = 0V$ , unless otherwise noted

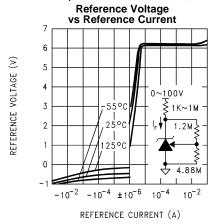
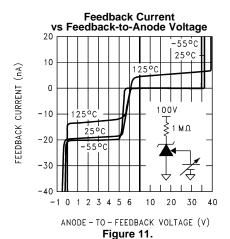
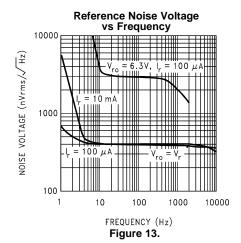
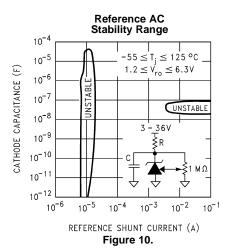
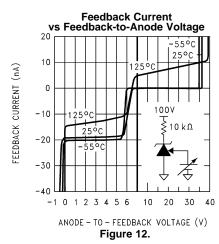


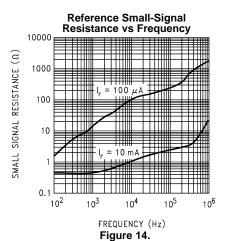
Figure 9.











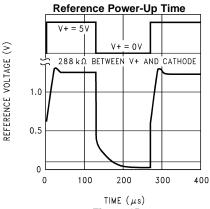


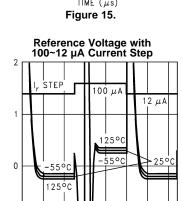
REFERENCE VOLTAGE CHANGE (mV)

0

# Typical Performance Characteristics (Reference) (continued)

 $T_J = 25$ °C, FEEDBACK pin shorted to  $V^- = 0V$ , unless otherwise noted





TIME (μs)

100 200 300 400 500 600 700

Figure 17.

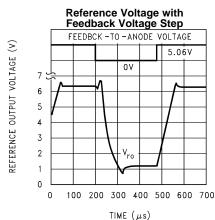


Figure 16.

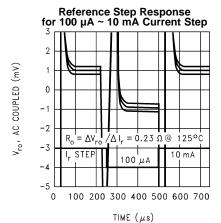


Figure 18.

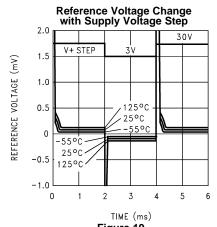
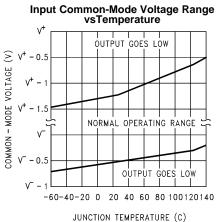


Figure 19.



### **Typical Performance Characteristics (Op Amps)**

 $V^+ = 5V$ ,  $V^- = GND = 0V$ ,  $V_{CM} = V^+/2$ ,  $V_{OUT} = V^+/2$ ,  $T_J = 25$ °C, unless otherwise noted





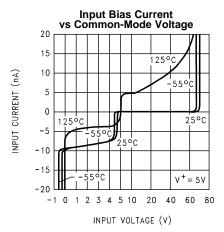
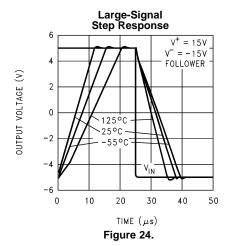


Figure 22.



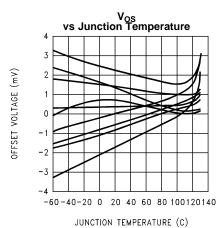


Figure 21.

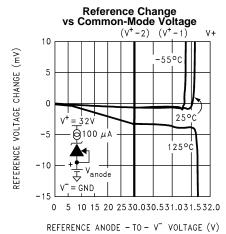
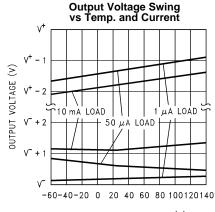


Figure 23.



JUNCTION TEMPERATURE (C) Figure 25.



# Typical Performance Characteristics (Op Amps) (continued)

 $V^+ = 5V$ ,  $V^- = GND = 0V$ ,  $V_{CM} = V^+/2$ ,  $V_{OUT} = V^+/2$ ,  $T_J = 25$ °C, unless otherwise noted

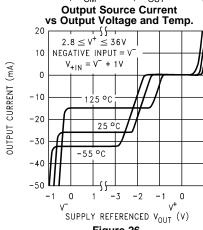


Figure 26.

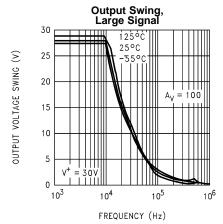
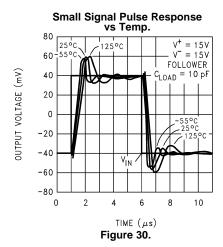
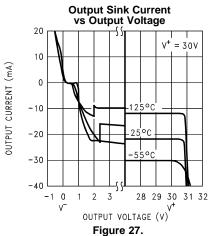
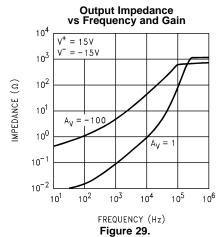


Figure 28.







vs Load 80 .50 pF, ∞ Ω 100 pF, 2 kΩ TO V<sup>+</sup> 60 OUTPUT VOLTAGE (mV) 40 20 V<sup>+</sup> = 15V . V<sup>-</sup> = 15V 0 **FOLLOWER** -20 -40 100 pF, 2 kΩ TO V<sup>+</sup>

100 pF, 2 kΩ TO V 50 pF,  $\infty$   $\Omega$ 

-60

-80

0

**Small-Signal Pulse Response** 

8 TIME  $(\mu s)$ Figure 31.

10



# Typical Performance Characteristics (Op Amps) (continued)

 $V^+ = 5V$ ,  $V^- = GND = 0V$ ,  $V_{CM} = V^+/2$ ,  $V_{OUT} = V^+/2$ ,  $T_J = 25$ °C, unless otherwise noted

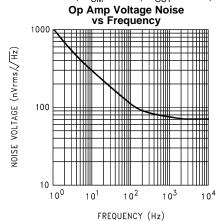
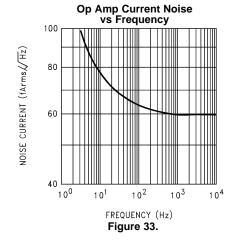


Figure 32.



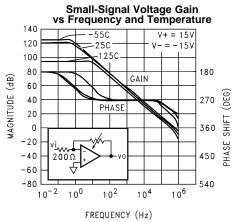


Figure 34.

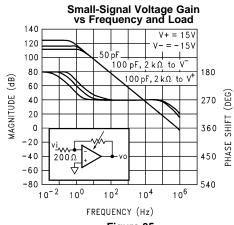
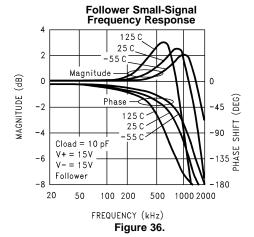


Figure 35.



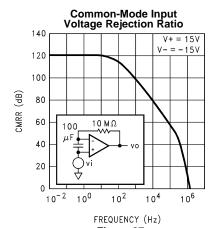
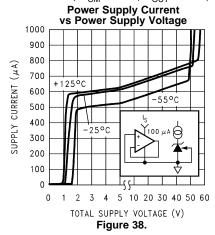


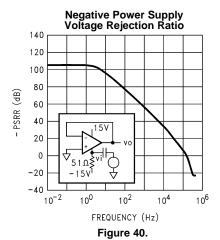
Figure 37.

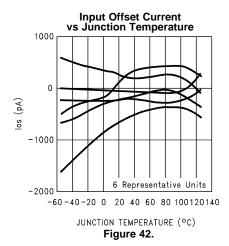


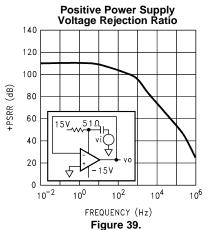
# Typical Performance Characteristics (Op Amps) (continued)

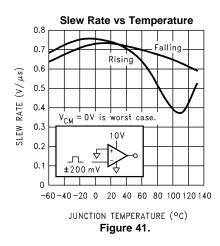
 $V^+ = 5V$ ,  $V^- = GND = 0V$ ,  $V_{CM} = V^+/2$ ,  $V_{OUT} = V^+/2$ ,  $T_J = 25$ °C, unless otherwise noted

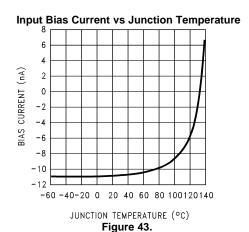






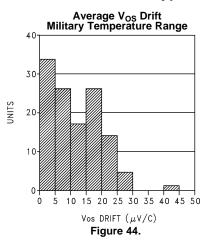


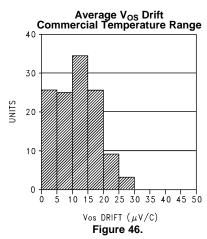


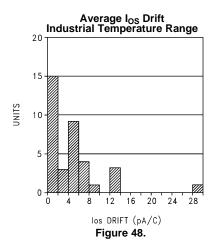


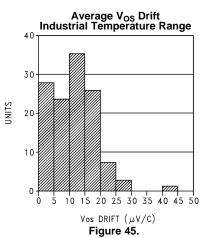


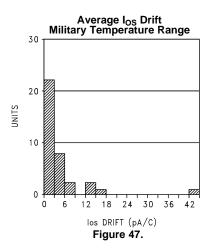
# **Typical Performance Distributions**

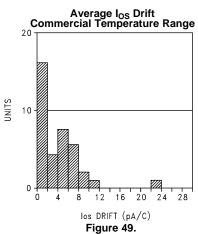




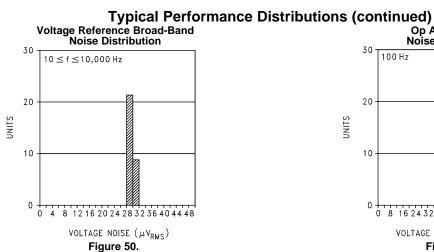


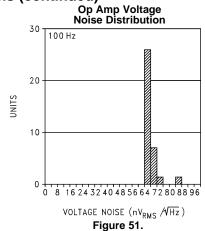


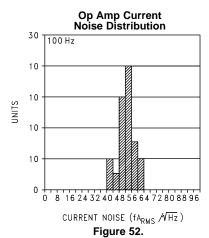














#### **APPLICATION INFORMATION**

#### **VOLTAGE REFERENCE**

#### Reference Biasing

The voltage reference is of a shunt regulator topology that models as a simple zener diode. With current  $I_r$  flowing in the 'forward' direction there is the familiar diode transfer function.  $I_r$  flowing in the reverse direction forces the reference voltage to be developed from cathode to anode. The applied voltage to the cathode may range from a diode drop below  $V^-$  to the reference voltage or to the avalanche voltage of the parallel protection diode, nominally 7V. A 6.3V reference with V+=3V is allowed.

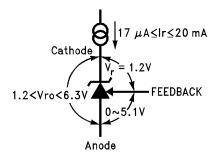


Figure 53. Voltages Associated with Reference (Current Source I<sub>r</sub> is External)

The reference equivalent circuit reveals how  $V_r$  is held at the constant 1.2V by feedback, and how the FEEDBACK pin passes little current.

To generate the required reverse current, typically a resistor is connected from a supply voltage higher than the reference voltage. Varying that voltage, and so varying  $I_r$ , has small effect with the equivalent series resistance of less than an ohm at the higher currents. Alternatively, an active current source, such as the LM134 series, may generate  $I_r$ .

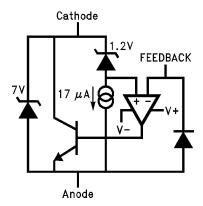


Figure 54. Reference Equivalent Circuit

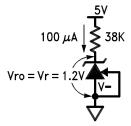


Figure 55. 1.2V Reference

Product Folder Links: LM611



Capacitors in parallel with the reference are allowed. See the Reference AC Stability Range curve for capacitance values—from 20  $\mu$ A to 3 mA any capacitor value is stable. With the reference's wide stability range with resistive and capacitive loads, a wide range of RC filter values will perform noise filtering.

#### **Adjustable Reference**

The FEEDBACK pin allows the reference output voltage,  $V_{ro}$ , to vary from 1.24V to 6.3V. The reference attempts to hold  $V_r$  at 1.24V. If  $V_r$  is above 1.24V, the reference will conduct current from Cathode to Anode; FEEDBACK current always remains low. If FEEDBACK is connected to Anode, then  $V_{ro} = V_r = 1.24V$ . For higher voltages FEEDBACK is held at a constant voltage above Anode—say 3.76V for  $V_{ro} = 5V$ . Connecting a resistor across the constant  $V_r$  generates a current I=R1/ $V_r$  flowing from Cathode into FEEDBACK node. A Thevenin equivalent 3.76V is generated from FEEDBACK to Anode with R2=3.76/I. Keep I greater than one thousand times larger than FEEDBACK bias current for <0.1% error—I≥32  $\mu$ A for the military grade over the military temperature range (I≥5.5  $\mu$ A for a 1% untrimmed error for a commercial part.)

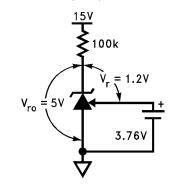
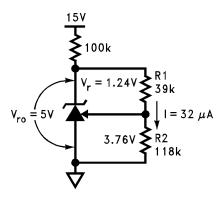


Figure 56. Thevenin Equivalent of Reference with 5V Output



R1 = Vr/I = 1.24/32 $\mu$  = 39k R2 = R1 {(Vro/Vr) - 1} = 39k {(5/1.24) - 1)} = 118k

Figure 57. Resistors R1 and R2 Program Reference Output Voltage to be 5V

Understanding that  $V_r$  is fixed and that voltage sources, resistors, and capacitors may be tied to the FEEDBACK pin, a range of  $V_r$  temperature coefficients may be synthesized.



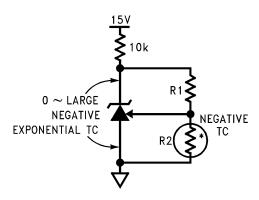


Figure 58. Output Voltage has Negative Temperature Coefficient (TC) if R2 has Negative TC

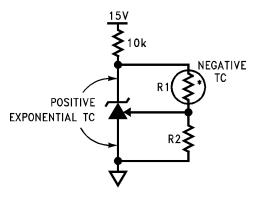


Figure 59. Output Voltage has Positive TC if R1 has Negative TC

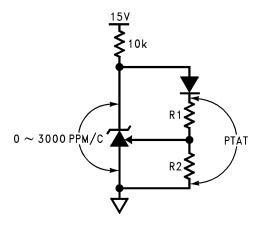
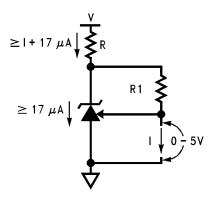


Figure 60. Diode in Series with R1 Causes Voltage Across R1 and R2 to be Proportional to Absolute Temperature (PTAT)

Connecting a resistor across Cathode-to-FEEDBACK creates a 0 TC current source, but a range of TCs may be synthesized.





I = Vr/R1 = 1.24/R1

Figure 61. Current Source is Programmed by R1

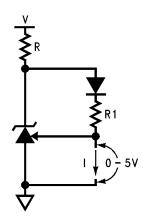


Figure 62. Proportional-to-Absolute-Temperature Current Source

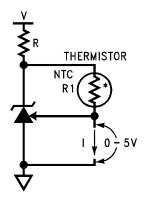


Figure 63. Negative -TC Current Source

### **Hysteresis**

The reference voltage depends, slightly, on the thermal history of the die. Competitive micro-power products vary—always check the data sheet for any given device. Do not assume that no specification means no hysteresis.



#### **OPERATIONAL AMPLIFIER**

The amp or the reference may be biased in any way with no effect on the other, except when a substrate diode conducts (see <sup>(1)</sup> under Electrical Characteristics). The amp may have inputs outside the common-mode range, may be operated as a comparator, or have all terminals floating with no effect on the reference (tying inverting input to output and non-inverting input to V<sup>-</sup> on unused amp is preferred). Choosing operating points that cause oscillation, such as driving too large a capacitive load, is best avoided.

#### **Op Amp Output Stage**

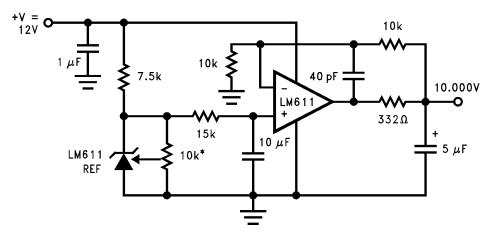
The op amp, like the LM124 series, has a flexible and relatively wide-swing output stage. There are simple rules to optimize output swing, reduce cross-over distortion, and optimize capacitive drive capability:

- 1. Output Swing: Unloaded, the 42  $\mu$ A pull-down will bring the output within 300 mV of V<sup>-</sup> over the military temperature range. If more than 42  $\mu$ A is required, a resistor from output to V<sup>-</sup> will help. Swing across any load may be improved slightly if the load can be tied to V<sup>+</sup>, at the cost of poorer sinking open-loop voltage gain.
- Cross-over Distortion: The LM611 has lower cross-over distortion (a 1 V<sub>BE</sub> deadband versus 3 V<sub>BE</sub> for the LM124), and increased slew rate as shown in the Typical Performance Charactersitics curves. A resistor pullup or pull-down will force class-A operation with only the PNP or NPN output transistor conducting, eliminating cross-over distortion.
- 3. Capacitive Drive: Limited by the output pole caused by the output resistance driving capacitive loads, a pull-down resistor conducting 1 mA or more reduces the output stage NPN  $r_e$  until the output resistance is that of the current limit 25 $\Omega$ . 200 pF may then be driven without oscillation.

### **Op Amp Input Stage**

The lateral PNP input transistors, unlike those of most op amps, have  $BV_{EBO}$  equal to the absolute maximum supply voltage. Also, they have no diode clamps to the positive supply nor across the inputs. These features make the inputs look like high impedances to input sources producing large differential and common-mode voltages.

### **Typical Applications**



\*10k must be low t.c. trim pot.

Figure 64. Ultra Low Noise 10.00V Reference. Total Output Noise is Typically 14  $\mu V_{RMS}$ . Adjust the 10k pot for 10.000V.

(1) Absolute maximum ratings indicate limits beyond which damage to the component may occur. Electrical specifications do not apply when operating the device beyond its rated operating conditions.



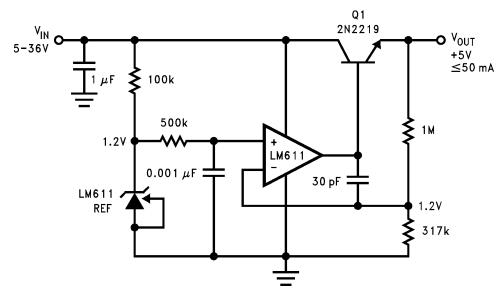
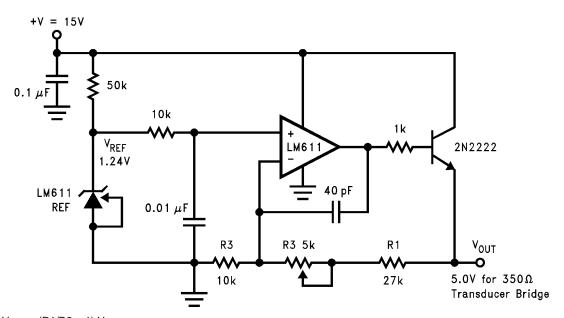


Figure 65. Simple Low Quiescent Drain Voltage Regulator. Total Supply Current is approximately 320  $\mu$ A when  $V_{\text{IN}}=5V$ , and output has no load.



$$\begin{split} &V_{OUT} = (R1/R2 + 1) \ V_{REF}. \\ &R1, \ R2 \ should \ be \ 1\% \ metal \ film. \\ &R3 \ should \ be \ low \ t.c. \ trim \ pot. \end{split}$$

Figure 66. Slow Rise-Time Upon Power-Up, Adjustable Transducer Bridge Driver. Rise-time is approximately 0.5 ms.



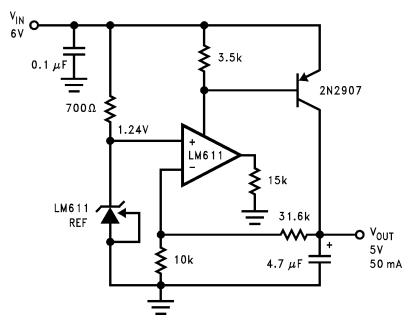


Figure 67. Low Drop-Out Voltage Regulator Circuit. Drop out voltage is typically 0.2V.

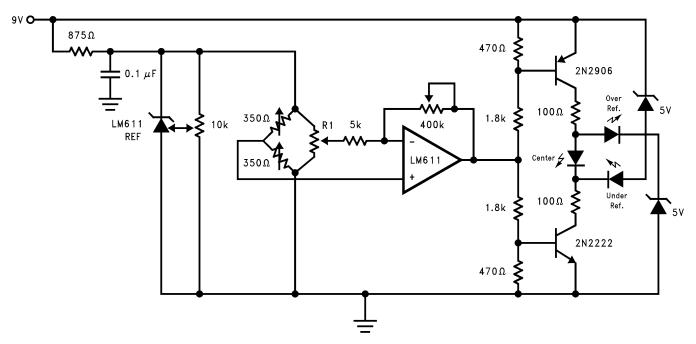


Figure 68. Nulling Bridge Detection System. Adjust sensitivity via 400 k $\Omega$  pot. Null offset with R1, and bridge drive with the 10k pot.



# **Simplified Schematic Diagrams**

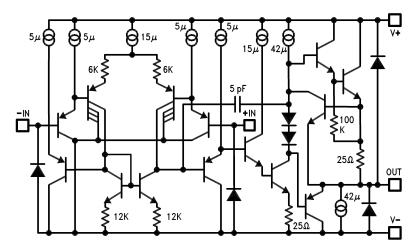


Figure 69. Op Amp

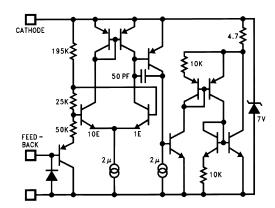


Figure 70. Reference

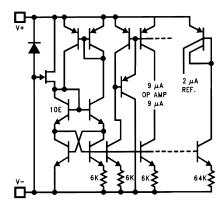


Figure 71. Bias



# **REVISION HISTORY**

| Changes from Revision B (March 2013) to Revision C  Pag  Changed levest of National Data Shoot to TI format |  |    |  |
|---|--|----|--|
| •   | Changed layout of National Data Sheet to TI format | 21 |  |





12-Oct-2014

#### **PACKAGING INFORMATION**

| Orderable Device | Status | Package Type | Package<br>Drawing | Pins | Package<br>Qty | Eco Plan                   | Lead/Ball Finish | MSL Peak Temp      | Op Temp (°C) | Device Marking<br>(4/5) | Samples |
|------------------|--------|--------------|--------------------|------|----------------|----------------------------|------------------|--------------------|--------------|-------------------------|---------|
| LM611CM/NOPB     | ACTIVE | SOIC         | D                  | 14   | 55             | Green (RoHS<br>& no Sb/Br) | CU SN            | Level-1-260C-UNLIM | 0 to 70      | LM611CM                 | Samples |
| LM611CMX/NOPB    | ACTIVE | SOIC         | D                  | 14   | 2500           | Green (RoHS<br>& no Sb/Br) | CU SN            | Level-1-260C-UNLIM | 0 to 70      | LM611CM                 | Samples |
| LM611IM/NOPB     | ACTIVE | SOIC         | D                  | 14   | 55             | Green (RoHS<br>& no Sb/Br) | CU SN            | Level-1-260C-UNLIM | -40 to 85    | LM611IM                 | Samples |
| LM611IMX/NOPB    | ACTIVE | SOIC         | D                  | 14   | 2500           | Green (RoHS<br>& no Sb/Br) | CU SN            | Level-1-260C-UNLIM | -40 to 85    | LM611IM                 | Samples |

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.



# **PACKAGE OPTION ADDENDUM**

12-Oct-2014

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

# **PACKAGE MATERIALS INFORMATION**

www.ti.com 23-Sep-2013

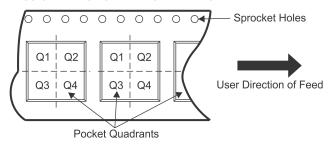
# TAPE AND REEL INFORMATION





|    | Dimension designed to accommodate the component width     |
|----|---|
|    | Dimension designed to accommodate the component length    |
| K0 | Dimension designed to accommodate the component thickness |
| W  | Overall width of the carrier tape                         |
| P1 | Pitch between successive cavity centers                   |

### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

| Device        | Package<br>Type | Package<br>Drawing |    | SPQ  | Reel<br>Diameter<br>(mm) | Reel<br>Width<br>W1 (mm) | A0<br>(mm) | B0<br>(mm) | K0<br>(mm) | P1<br>(mm) | W<br>(mm) | Pin1<br>Quadrant |
|---------------|-----------------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| LM611CMX/NOPB | SOIC            | D                  | 14 | 2500 | 330.0                    | 16.4                     | 6.5        | 9.35       | 2.3        | 8.0        | 16.0      | Q1               |
| LM611IMX/NOPB | SOIC            | D                  | 14 | 2500 | 330.0                    | 16.4                     | 6.5        | 9.35       | 2.3        | 8.0        | 16.0      | Q1               |

www.ti.com 23-Sep-2013



#### \*All dimensions are nominal

| Device        | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|---------------|--------------|-----------------|------|------|-------------|------------|-------------|
| LM611CMX/NOPB | SOIC         | D               | 14   | 2500 | 367.0       | 367.0      | 35.0        |
| LM611IMX/NOPB | SOIC         | D               | 14   | 2500 | 367.0       | 367.0      | 35.0        |

# D (R-PDSO-G14)

# PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AB.



#### IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46, latest issue, and to discontinue any product or service per JESD48, latest issue. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All semiconductor products (also referred to herein as "components") are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its components to the specifications applicable at the time of sale, in accordance with the warranty in TI's terms and conditions of sale of semiconductor products. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by applicable law, testing of all parameters of each component is not necessarily performed.

TI assumes no liability for applications assistance or the design of Buyers' products. Buyers are responsible for their products and applications using TI components. To minimize the risks associated with Buyers' products and applications, Buyers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI components or services are used. Information published by TI regarding third-party products or services does not constitute a license to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of significant portions of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI components or services with statements different from or beyond the parameters stated by TI for that component or service voids all express and any implied warranties for the associated TI component or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyer acknowledges and agrees that it is solely responsible for compliance with all legal, regulatory and safety-related requirements concerning its products, and any use of TI components in its applications, notwithstanding any applications-related information or support that may be provided by TI. Buyer represents and agrees that it has all the necessary expertise to create and implement safeguards which anticipate dangerous consequences of failures, monitor failures and their consequences, lessen the likelihood of failures that might cause harm and take appropriate remedial actions. Buyer will fully indemnify TI and its representatives against any damages arising out of the use of any TI components in safety-critical applications.

In some cases, TI components may be promoted specifically to facilitate safety-related applications. With such components, TI's goal is to help enable customers to design and create their own end-product solutions that meet applicable functional safety standards and requirements. Nonetheless, such components are subject to these terms.

No TI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Only those TI components which TI has specifically designated as military grade or "enhanced plastic" are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have *not* been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components as meeting ISO/TS16949 requirements, mainly for automotive use. In any case of use of non-designated products, TI will not be responsible for any failure to meet ISO/TS16949.

#### Products Applications

Audio www.ti.com/audio Automotive and Transportation www.ti.com/automotive Communications and Telecom Amplifiers amplifier.ti.com www.ti.com/communications **Data Converters** dataconverter.ti.com Computers and Peripherals www.ti.com/computers **DLP® Products** www.dlp.com Consumer Electronics www.ti.com/consumer-apps

DSP **Energy and Lighting** dsp.ti.com www.ti.com/energy Clocks and Timers www.ti.com/clocks Industrial www.ti.com/industrial Interface interface.ti.com Medical www.ti.com/medical logic.ti.com Logic Security www.ti.com/security

Power Mgmt power.ti.com Space, Avionics and Defense www.ti.com/space-avionics-defense

Microcontrollers <u>microcontroller.ti.com</u> Video and Imaging <u>www.ti.com/video</u>

RFID <u>www.ti-rfid.com</u>

OMAP Applications Processors <u>www.ti.com/omap</u> TI E2E Community <u>e2e.ti.com</u>

Wireless Connectivity <u>www.ti.com/wirelessconnectivity</u>